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	Application Number		10829032	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Not for submission under 37 CFR 1.99)	Filing Date		2004-04-21	
	First Named Inventor	David	J. Marshall	
	Art Unit		3691	
	Examiner Name	Naray	vanswamy Subramanian	
	Attorney Docket Numb	ber 006878.112404		

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